

## FDS5672

### N-Channel PowerTrench® MOSFET

60V, 12A, 10mΩ

#### Features

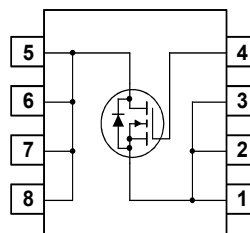
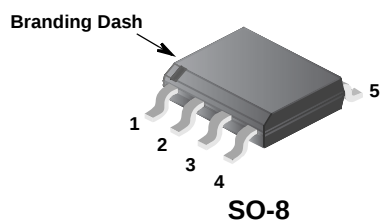
- $r_{DS(ON)} = 10m\Omega$ ,  $V_{GS} = 10V$ ,  $I_D = 12A$
- $r_{DS(ON)} = 14m\Omega$ ,  $V_{GS} = 6V$ ,  $I_D = 10A$
- High performance trench technology for extremely low  $r_{DS(ON)}$
- Low gate charge
- High power and current handling capability

#### Applications

- DC/DC converters

#### General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(ON)}$  and fast switching speed.



**MOSFET Maximum Ratings**  $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol         | Parameter                                                                                              | Ratings    | Units                |
|----------------|--------------------------------------------------------------------------------------------------------|------------|----------------------|
| $V_{DSS}$      | Drain to Source Voltage                                                                                | 60         | V                    |
| $V_{GS}$       | Gate to Source Voltage                                                                                 | $\pm 20$   | V                    |
| $I_D$          | Drain Current                                                                                          |            |                      |
|                | Continuous ( $T_C = 25^\circ\text{C}$ , $V_{GS} = 10\text{V}$ , $R_{\theta JA} = 50^\circ\text{C/W}$ ) | 12         | A                    |
|                | Continuous ( $T_C = 25^\circ\text{C}$ , $V_{GS} = 6\text{V}$ , $R_{\theta JA} = 50^\circ\text{C/W}$ )  | 10         |                      |
|                | Pulsed                                                                                                 | Figure 4   | A                    |
| $E_{AS}$       | Single Pulse Avalanche Energy (Note 1)                                                                 | 245        | mJ                   |
| $P_D$          | Power dissipation                                                                                      | 2.5        | W                    |
|                | Derate above $25^\circ\text{C}$                                                                        | 20         | mW/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature                                                                      | -55 to 150 | $^\circ\text{C}$     |

**Thermal Characteristics**

|                 |                                                                 |    |                    |
|-----------------|-----------------------------------------------------------------|----|--------------------|
| $R_{\theta JC}$ | Thermal Resistance Junction to Case (Note 2)                    | 25 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient at 10 seconds (Note 3)   | 50 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient at 1000 seconds (Note 3) | 85 | $^\circ\text{C/W}$ |

**Package Marking and Ordering Information**

| Device Marking | Device  | Package | Reel Size | Tape Width | Quantity   |
|----------------|---------|---------|-----------|------------|------------|
| FDS5672        | FDS5672 | SO-8    | 330mm     | 12mm       | 2500 units |

**Electrical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|            |                                   |                                               |    |   |           |               |
|------------|-----------------------------------|-----------------------------------------------|----|---|-----------|---------------|
| $B_{VDSS}$ | Drain to Source Breakdown Voltage | $I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$ | 60 | - | -         | V             |
| $I_{DSS}$  | Zero Gate Voltage Drain Current   | $V_{DS} = 50\text{V}$<br>$V_{GS} = 0\text{V}$ | -  | - | 1         | $\mu\text{A}$ |
|            |                                   | $T_C = 150^\circ\text{C}$                     | -  | - | 250       |               |
| $I_{GSS}$  | Gate to Source Leakage Current    | $V_{GS} = \pm 20\text{V}$                     | -  | - | $\pm 100$ | nA            |

**On Characteristics**

|              |                                  |                                                                           |   |        |       |          |
|--------------|----------------------------------|---------------------------------------------------------------------------|---|--------|-------|----------|
| $V_{GS(TH)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}$ , $I_D = 250\mu\text{A}$                                | 2 | -      | 4     | V        |
| $r_{DS(ON)}$ | Drain to Source On Resistance    | $I_D = 12\text{A}$ , $V_{GS} = 10\text{V}$                                | - | 0.0088 | 0.010 | $\Omega$ |
|              |                                  | $I_D = 10\text{A}$ , $V_{GS} = 6\text{V}$                                 | - | 0.012  | 0.014 |          |
|              |                                  | $I_D = 12\text{A}$ , $V_{GS} = 10\text{V}$ ,<br>$T_C = 150^\circ\text{C}$ | - | 0.016  | 0.023 |          |

**Dynamic Characteristics**

|              |                                  |                                                                     |   |      |     |          |
|--------------|----------------------------------|---------------------------------------------------------------------|---|------|-----|----------|
| $C_{ISS}$    | Input Capacitance                | $V_{DS} = 25\text{V}$ , $V_{GS} = 0\text{V}$ ,<br>$f = 1\text{MHz}$ | - | 2200 | -   | pF       |
| $C_{OSS}$    | Output Capacitance               |                                                                     | - | 410  | -   | pF       |
| $C_{RSS}$    | Reverse Transfer Capacitance     |                                                                     | - | 130  | -   | pF       |
| $R_G$        | Gate Resistance                  | $V_{GS} = 0.5\text{V}$ , $f = 1\text{MHz}$                          | - | 1.4  | -   | $\Omega$ |
| $Q_{g(TOT)}$ | Total Gate Charge at 10V         | $V_{GS} = 0\text{V}$ to 10V                                         | - | 34   | 45  | nC       |
| $Q_{g(TH)}$  | Threshold Gate Charge            | $V_{GS} = 0\text{V}$ to 2V                                          | - | 4.2  | 5.5 | nC       |
| $Q_{gs}$     | Gate to Source Gate Charge       | $V_{DD} = 30\text{V}$<br>$I_D = 12\text{A}$<br>$I_g = 1.0\text{mA}$ | - | 9.4  | -   | nC       |
| $Q_{gs2}$    | Gate Charge Threshold to Plateau |                                                                     | - | 5.2  | -   | nC       |
| $Q_{gd}$     | Gate to Drain "Miller" Charge    |                                                                     | - | 9.3  | -   | nC       |

**Resistive Switching Characteristics** ( $V_{GS} = 10V$ )

|              |                     |                                                                 |   |    |    |    |
|--------------|---------------------|-----------------------------------------------------------------|---|----|----|----|
| $t_{ON}$     | Turn-On Time        | $V_{DD} = 30V, I_D = 12A$<br>$V_{GS} = 10V, R_{GS} = 9.1\Omega$ | - | -  | 50 | ns |
| $t_{d(ON)}$  | Turn-On Delay Time  |                                                                 | - | 13 | -  | ns |
| $t_r$        | Rise Time           |                                                                 | - | 20 | -  | ns |
| $t_{d(OFF)}$ | Turn-Off Delay Time |                                                                 | - | 35 | -  | ns |
| $t_f$        | Fall Time           |                                                                 | - | 14 | -  | ns |
| $t_{OFF}$    | Turn-Off Time       |                                                                 | - | -  | 64 | ns |

**Drain-Source Diode Characteristics**

|          |                               |                                       |   |   |      |    |
|----------|-------------------------------|---------------------------------------|---|---|------|----|
| $V_{SD}$ | Source to Drain Diode Voltage | $I_{SD} = 12A$                        | - | - | 1.25 | V  |
|          |                               | $I_{SD} = 6A$                         | - | - | 1.0  | V  |
| $t_{rr}$ | Reverse Recovery Time         | $I_{SD}=12A, dI_{SD}/dt = 100A/\mu s$ | - | - | 39   | ns |
| $Q_{RR}$ | Reverse Recovered Charge      | $I_{SD}=12A, dI_{SD}/dt = 100A/\mu s$ | - | - | 40   | nC |

**Notes:**

1: Starting  $T_J = 25^\circ C$ ,  $L = 1mH$ ,  $I_{AS} = 22A$ ,  $V_{DD} = 60V$ ,  $V_{GS} = 10V$ .

2:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.

3:  $R_{\theta JA}$  is measured with 1.0 in<sup>2</sup> copper on FR-4 board.

## Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

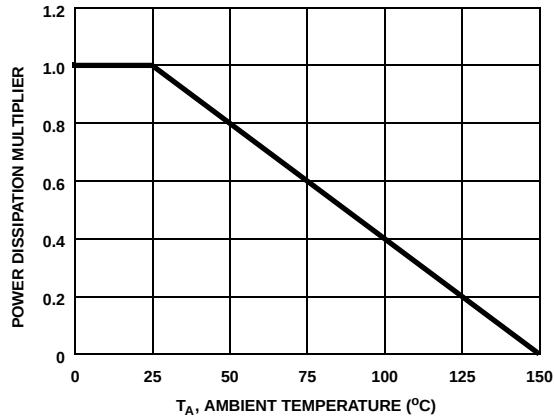


Figure 1. Normalized Power Dissipation vs Ambient Temperature

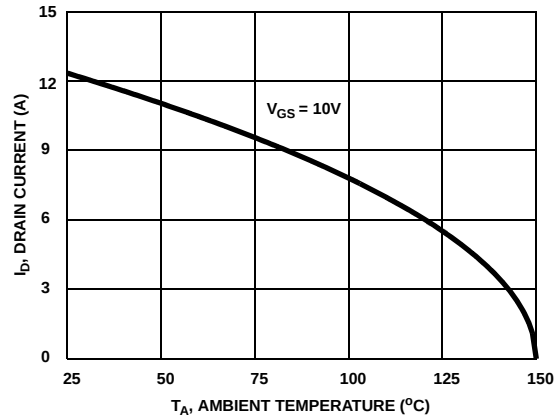


Figure 2. Maximum Continuous Drain Current vs Ambient Temperature

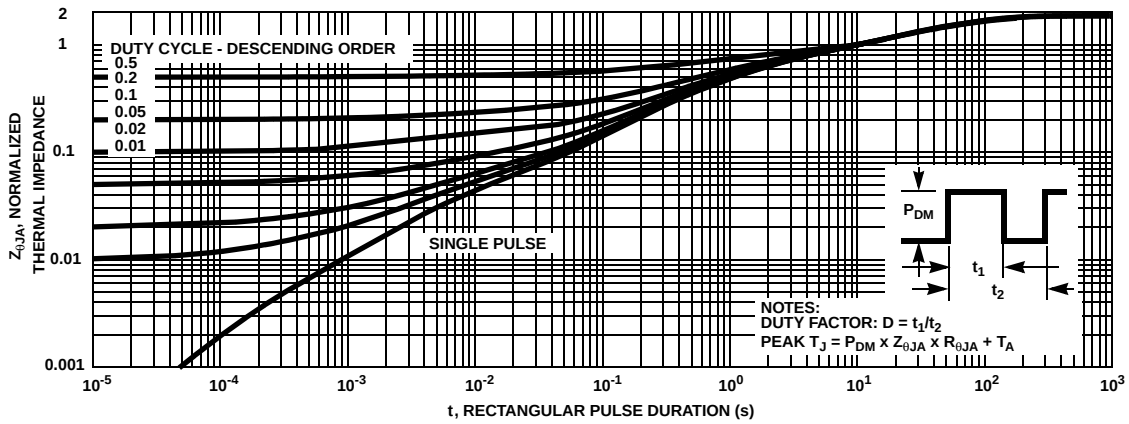


Figure 3. Normalized Maximum Transient Thermal Impedance

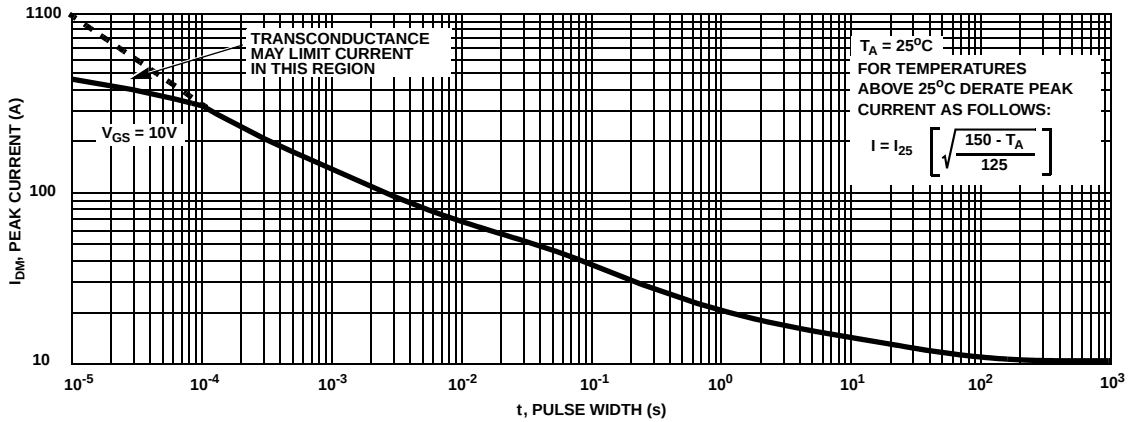
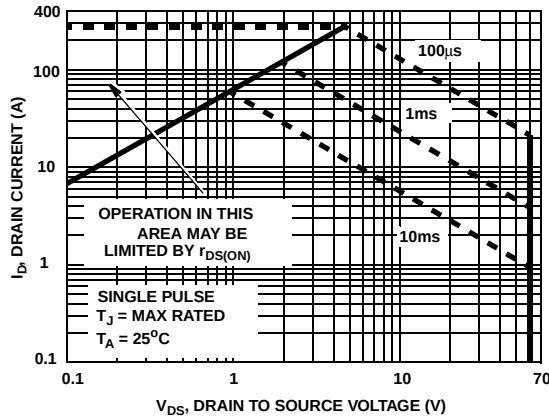
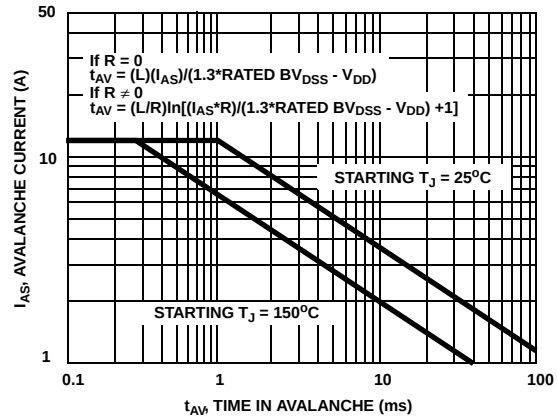


Figure 4. Peak Current Capability

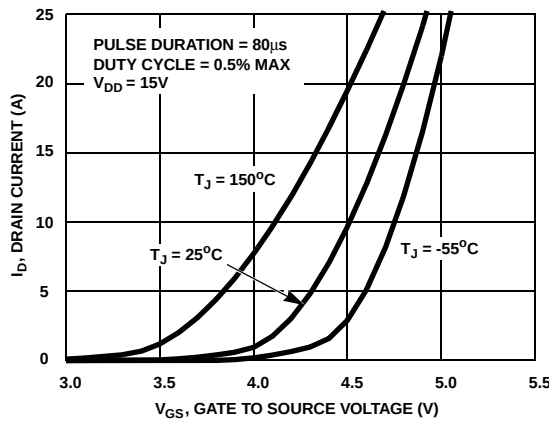
## Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted



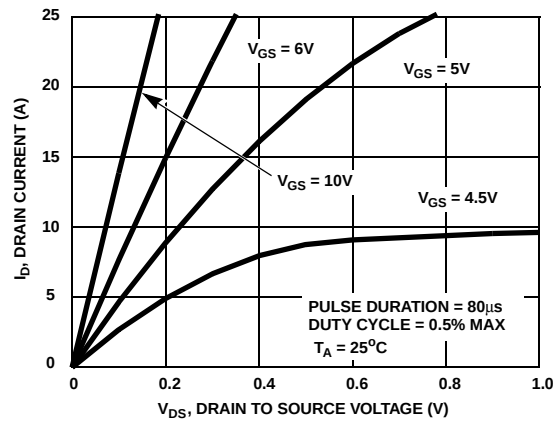
**Figure 5. Forward Bias Safe Operating Area**



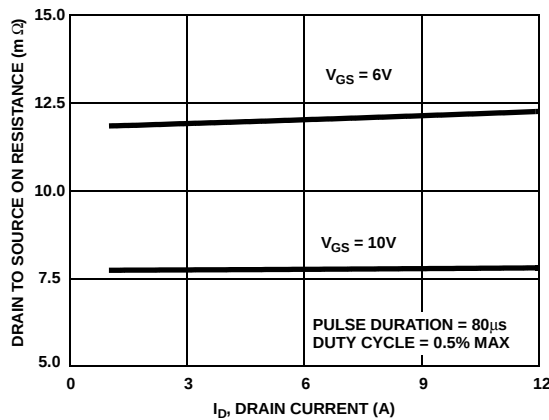
NOTE: Refer to Fairchild Application Notes AN7514 and AN7515  
**Figure 6. Unclamped Inductive Switching Capability**



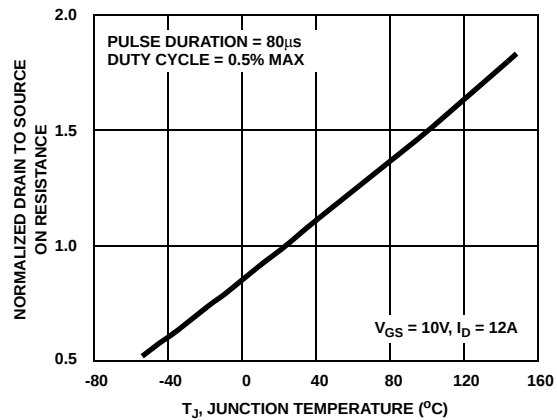
**Figure 7. Transfer Characteristics**



**Figure 8. Saturation Characteristics**

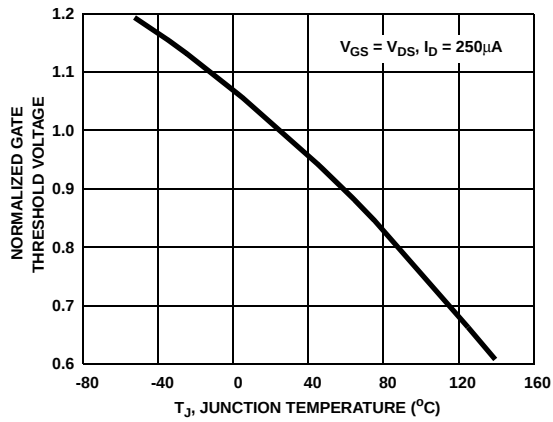


**Figure 9. Drain to Source On Resistance vs Drain Current**

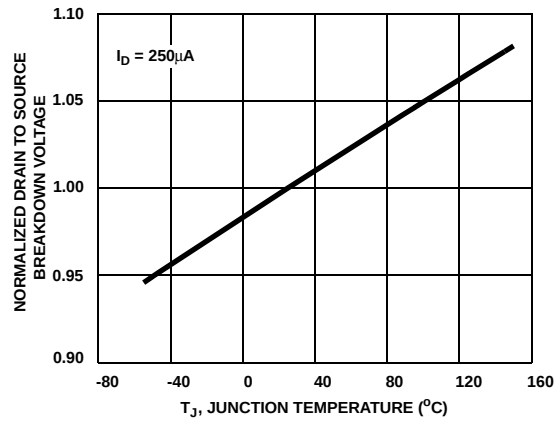


**Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature**

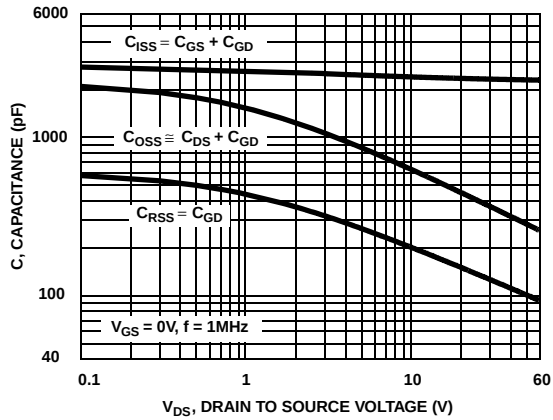
**Typical Characteristics**  $T_C = 25^\circ\text{C}$  unless otherwise noted



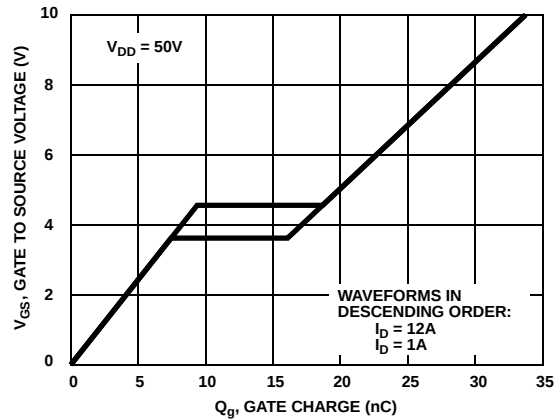
**Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature**



**Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature**



**Figure 13. Capacitance vs Drain to Source Voltage**



**Figure 14. Gate Charge Waveforms for Constant Gate Currents**

## Test Circuits and Waveforms

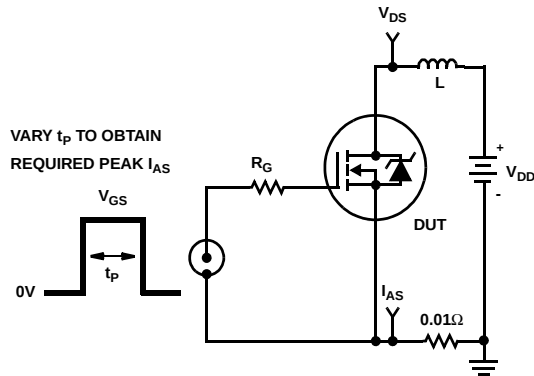


Figure 15. Unclamped Energy Test Circuit

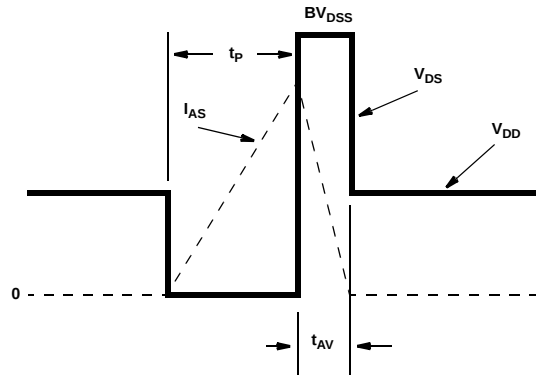


Figure 16. Unclamped Energy Waveforms

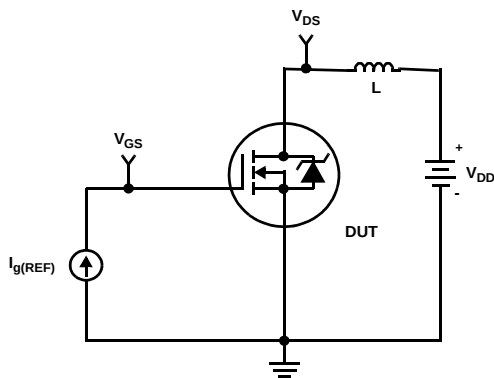


Figure 17. Gate Charge Test Circuit

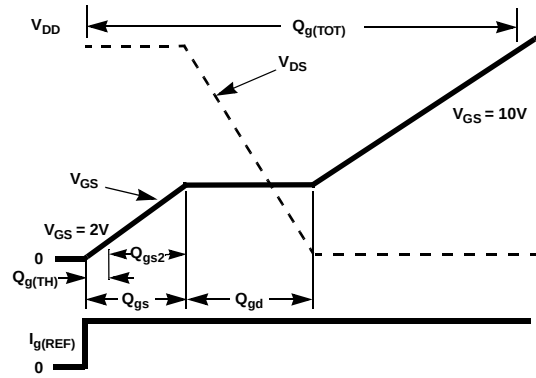


Figure 18. Gate Charge Waveforms

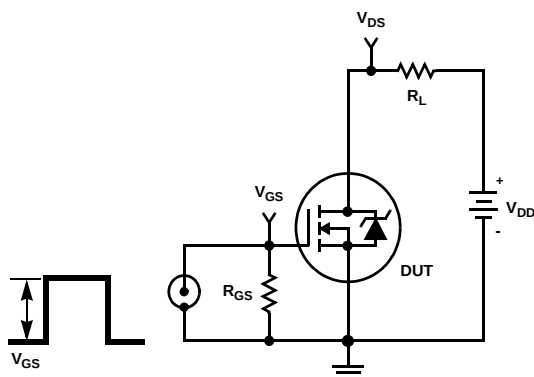


Figure 19. Switching Time Test Circuit

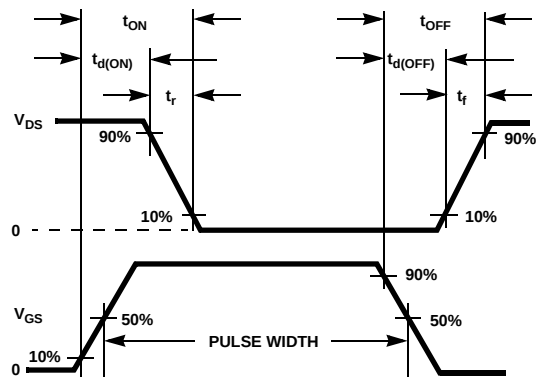


Figure 20. Switching Time Waveforms

## Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature,  $T_{JM}$ , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation,  $P_{DM}$ , in an application. Therefore the application's ambient temperature,  $T_A$  ( $^{\circ}\text{C}$ ), and thermal resistance  $R_{\theta JA}$  ( $^{\circ}\text{C/W}$ ) must be reviewed to ensure that  $T_{JM}$  is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}} \quad (\text{EQ. 1})$$

In using surface mount devices such as the SO8 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of  $P_{DM}$  is complex and influenced by many factors:

1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
2. The number of copper layers and the thickness of the board.
3. The use of external heat sinks.
4. The use of thermal vias.
5. Air flow and board orientation.
6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the  $R_{\theta JA}$  for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized

maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2. The area, in square inches is the top copper area including the gate and source pads.

$$R_{\theta JA} = 64 + \frac{26}{0.23 + \text{Area}} \quad (\text{EQ. 2})$$

The transient thermal impedance ( $Z_{\theta JA}$ ) is also effected by varied top copper board area. Figure 22 shows the effect of copper pad area on single pulse transient thermal impedance. Each trace represents a copper pad area in square inches corresponding to the descending list in the graph. Spice and SABER thermal models are provided for each of the listed pad areas.

Copper pad area has no perceivable effect on transient thermal impedance for pulse widths less than 100ms. For pulse widths less than 100ms the transient thermal impedance is determined by the die and package. Therefore, CTERM1 through CTERM5 and RTERM1 through RTERM5 remain constant for each of the thermal models. A listing of the model component values is available in Table 1.

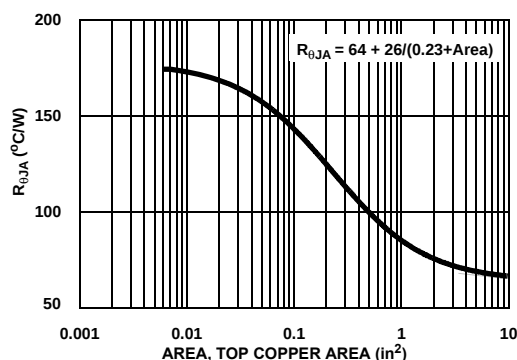


Figure 21. Thermal Resistance vs Mounting Pad Area

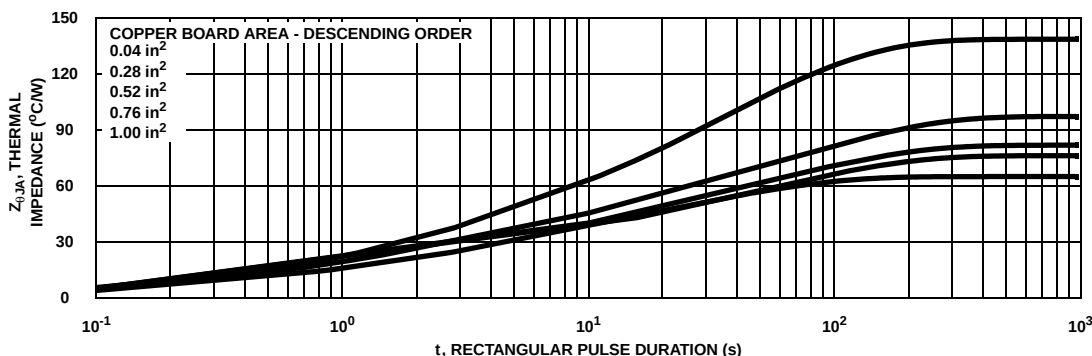


Figure 22. Thermal Impedance vs Mounting Pad Area

## PSPICE Electrical Model

.SUBCKT FDS5672 2 1 3 ; rev June 2005

Ca 12 8 7e-10

Cb 15 14 7e-10

Cin 6 8 2.2e-10

Dbody 7 5 DbodyMOD  
Dbreak 5 11 DbreakMOD  
Dplcap 10 5 DplcapMOD

Ebreak 11 7 17 18 67  
Eds 14 8 5 8 1  
Egs 13 8 6 8 1  
Esg 6 10 6 8 1  
Evthres 6 21 19 8 1  
Evtemp 20 6 18 22 1

It 8 17 1

Lgate 1 9 1.23e-9  
Ldrain 2 5 1.0e-9  
Lsource 3 7 0.18e-9

RLgate 1 9 12.3  
RLdrain 2 5 10  
RLsource 3 7 1.8

Mmed 16 6 8 8 MmedMOD  
Mstro 16 6 8 8 MstroMOD  
Mweak 16 21 8 8 MweakMOD

Rbreak 17 18 RbreakMOD 1  
Rdrain 50 16 RdrainMOD 1e-3  
Rgate 9 20 1.4  
RSLC1 5 51 RSLCMOD 1.0e-6  
RSLC2 5 50 1.0e3  
Rsource 8 7 RsourceMOD 3.2e-3  
Rvthres 22 8 RvthresMOD 1  
Rvtemp 18 19 RvtempMOD 1  
S1a 6 12 13 8 S1AMOD  
S1b 13 12 13 8 S1BMOD  
S2a 6 15 14 13 S2AMOD  
S2b 13 15 14 13 S2BMOD

Vbat 22 19 DC 1

ESLC 51 50 VALUE={{(V(5,51)/ABS(V(5,51)))\*(PWR(V(5,51)/(1e-6\*250),2.5))}}

.MODEL DbodyMOD D (IS=4.5E-12 RS=4.7e-3 TRS1=1.5e-3 TRS2=2e-5  
+ CJO=1.6e-9 M=0.55 TT=1.8e-8 XTI=3.0)

.MODEL DbreakMOD D (RS=2.5 TRS1=1.0e-3 TRS2=1e-6)

.MODEL DplcapMOD D (CJO=6.0e-10 IS=1.0e-30 N=10 M=0.45)

.MODEL MmedMOD NMOS (VTO=3.35 KP=4 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=1.4)

.MODEL MstroMOD NMOS (VTO=3.93 KP=50 IS=1e-30 N=10 TOX=1 L=1u W=1u)

.MODEL MweakMOD NMOS (VTO=2.82 KP=0.04 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=14 RS=0.1)

.MODEL RbreakMOD RES (TC1=7e-4 TC2=-1.3e-7)

.MODEL RdrainMOD RES (TC1=1.0e-4 TC2=1e-5)

.MODEL RSLCMOD RES (TC1=1.0e-2 TC2=1e-7)

.MODEL RsourceMOD RES (TC1=1.0e-2 TC2=1.0e-6)

.MODEL RvthresMOD RES (TC1=-3.9e-3 TC2=-1.4e-5)

.MODEL RvtempMOD RES (TC1=-4e-3 TC2=2e-7)

.MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-4.0 VOFF=-2.0)

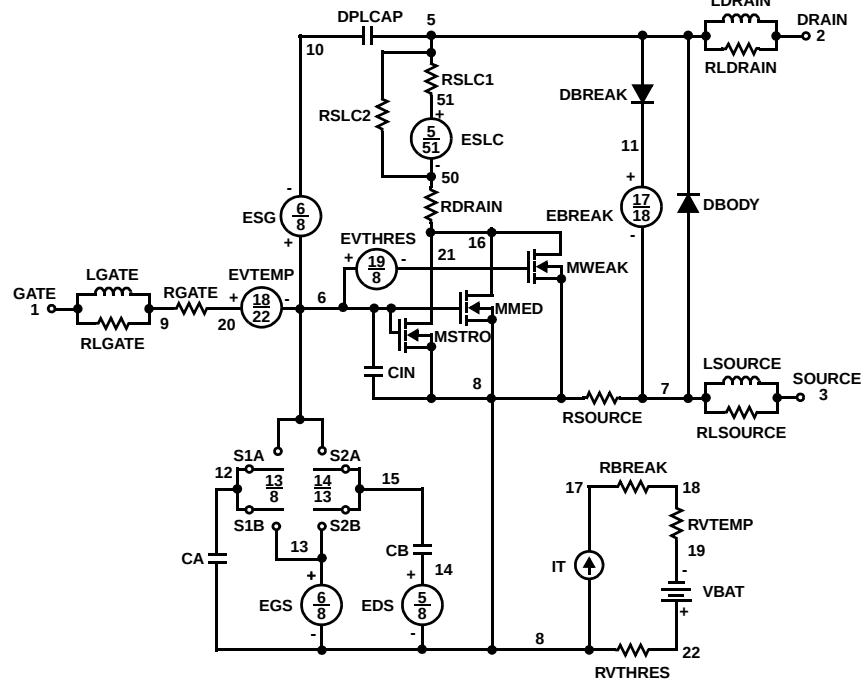
.MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-2.0 VOFF=-4.0)

.MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-0.5 VOFF=0)

.MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=0 VOFF=-0.5)

.ENDS

Note: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



**FDS5672 N-Channel PowerTrench® MOSFET**

## SPICE Thermal Model

REV June 2005

FDS5672\_JA Junction Ambient  
Copper Area = 1sq.in

CTHERM1 TH 8 2e-3  
CTHERM2 8 7 5e-3  
CTHERM3 7 6 1e-2  
CTHERM4 6 5 4e-2  
CTHERM5 5 4 9e-2  
CTHERM6 4 3 2e-1  
CTHERM7 3 2 1  
CTHERM8 2 TL 3

RTHERM1 TH 8 1e-1  
RTHERM2 8 7 5e-1  
RTHERM3 7 6 1  
RTHERM4 6 5 5  
RTHERM5 5 4 8  
RTHERM6 4 3 12  
RTHERM7 3 2 18  
RTHERM8 2 TL 25

## SABER Thermal Model

SABER thermal model FDS5672  
Copper Area = 1sq.in  
template thermal\_model th tl  
thermal\_c th, tl

```
{
  ctherm.ctherm1 th 8 =2e-3
  ctherm.ctherm2 8 7 =5e-3
  ctherm.ctherm3 7 6 =1e-2
  ctherm.ctherm4 6 5 =4e-2
  ctherm.ctherm5 5 4 =9e-2
  ctherm.ctherm6 4 3 =2e-1
  ctherm.ctherm7 3 2 =1
  ctherm.ctherm8 2 tl =3
}
```

```
rrtherm.rtherm1 th 8 =1e-1
rrtherm.rtherm2 8 7 =5e-1
rrtherm.rtherm3 7 6 =1
rrtherm.rtherm4 6 5 =5
rrtherm.rtherm5 5 4 =8
rrtherm.rtherm6 4 3 =12
rrtherm.rtherm7 3 2 =18
rrtherm.rtherm8 2 tl =25
}
```

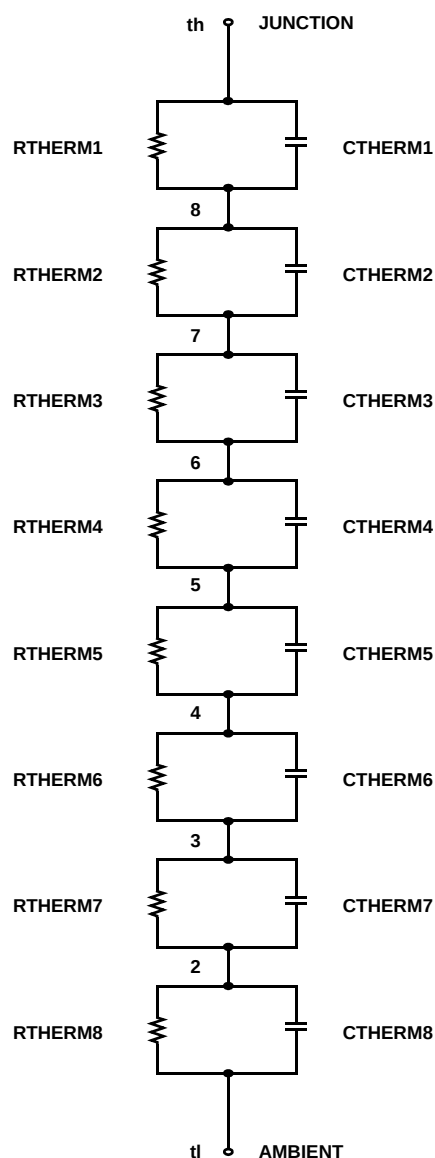


TABLE 1. THERMAL MODELS

| COMPONANT | 0.04 in <sup>2</sup> | 0.28 in <sup>2</sup> | 0.52 in <sup>2</sup> | 0.76 in <sup>2</sup> | 1.0 in <sup>2</sup> |
|-----------|----------------------|----------------------|----------------------|----------------------|---------------------|
| CTHERM6   | 1.2e-1               | 1.5e-1               | 2.0e-1               | 2.0e-1               | 2.0e-1              |
| CTHERM7   | 0.5                  | 1.0                  | 1.0                  | 1.0                  | 1.0                 |
| CTHERM8   | 1.3                  | 2.8                  | 3.0                  | 3.0                  | 3.0                 |
| RTHERM6   | 26                   | 20                   | 15                   | 13                   | 12                  |
| RTHERM7   | 39                   | 24                   | 21                   | 19                   | 18                  |
| RTHERM8   | 55                   | 38.7                 | 31.3                 | 29.7                 | 25                  |

## TRADEMARKS

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|                                                  |                                 |                                |                                 |                             |
|--------------------------------------------------|---------------------------------|--------------------------------|---------------------------------|-----------------------------|
| ACE <sup>™</sup>                                 | FACT Quiet Series <sup>™</sup>  | ImpliedDisconnect <sup>™</sup> | POP <sup>™</sup>                | Stealth <sup>™</sup>        |
| ActiveArray <sup>™</sup>                         | FAST <sup>®</sup>               | IntelliMAX <sup>™</sup>        | Power247 <sup>™</sup>           | SuperFET <sup>™</sup>       |
| Bottomless <sup>™</sup>                          | FAST <sup>™</sup>               | ISOPLANAR <sup>™</sup>         | PowerEdge <sup>™</sup>          | SuperSOT <sup>™</sup> -3    |
| CoolFET <sup>™</sup>                             | FPST <sup>™</sup>               | LittleFET <sup>™</sup>         | PowerSaver <sup>™</sup>         | SuperSOT <sup>™</sup> -6    |
| CROSSVOLT <sup>™</sup>                           | FRFET <sup>™</sup>              | MICROCOUPLER <sup>™</sup>      | PowerTrench <sup>®</sup>        | SuperSOT <sup>™</sup> -8    |
| DOVE <sup>™</sup>                                | GlobalOptoisolator <sup>™</sup> | MicroFET <sup>™</sup>          | QFET <sup>®</sup>               | SyncFET <sup>™</sup>        |
| EcoSPARK <sup>™</sup>                            | GTO <sup>™</sup>                | MicroPak <sup>™</sup>          | QS <sup>™</sup>                 | TinyLogic <sup>®</sup>      |
| E <sup>2</sup> CMOS <sup>™</sup>                 | HiSeC <sup>™</sup>              | MICROWIRE <sup>™</sup>         | QT Optoelectronics <sup>™</sup> | TINYOPTO <sup>™</sup>       |
| EnSigna <sup>™</sup>                             | I <sup>2</sup> C <sup>™</sup>   | MSX <sup>™</sup>               | Quiet Series <sup>™</sup>       | TruTranslation <sup>™</sup> |
| FACT <sup>™</sup>                                | i-Lo <sup>™</sup>               | MSXPro <sup>™</sup>            | RapidConfigure <sup>™</sup>     | UHC <sup>™</sup>            |
|                                                  |                                 | OCX <sup>™</sup>               | RapidConnect <sup>™</sup>       | UltraFET <sup>®</sup>       |
| Across the board. Around the world. <sup>™</sup> |                                 | OCXPro <sup>™</sup>            | µSerDes <sup>™</sup>            | UniFET <sup>™</sup>         |
| The Power Franchise <sup>®</sup>                 |                                 | OPTOLOGIC <sup>®</sup>         | SILENT SWITCHER <sup>®</sup>    | VCX <sup>™</sup>            |
| Programmable Active Droop <sup>™</sup>           |                                 | OPTOPLANAR <sup>™</sup>        | SMART START <sup>™</sup>        |                             |
|                                                  |                                 | PACMAN <sup>™</sup>            | SPM <sup>™</sup>                |                             |

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

## PRODUCT STATUS DEFINITIONS

### Definition of Terms

| Datasheet Identification | Product Status         | Definition                                                                                                                                                                                                            |
|--------------------------|------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Advance Information      | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.                                                                                    |
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